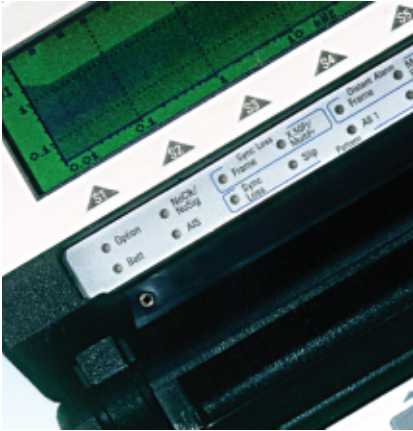


E1 and Data Testers

(PA-20, PA-25, PF-30, PFA-30, PFA-35)

Scalable testing for digital networks



Key Features

- Provides a scalable test solution for E1 and Data testing applications, supported by a large range of software options for E1 services (Frame Relay, GSM) and subrate multiplexing system (X.50, HCM, V.110) testing
- Allows for rapid evaluation of circuits through an intuitive user interface with an autoconfigure feature and large, clear results screens
- Employs a full set of physical layer tests for E1 balanced and unbalanced circuits including BERT, VF, Round Trip Delay and Jitter
- Provides standard options for Quality of Service (QoS) measurements to ITU-T G.821, G.826, and M.2100 recommendations
- Makes clear distinctions between bit errors and bit slips in QoS testing through the patented Gelbricht synchronization method
- Supports both remote operation (DTM-32) and remote control

The range of E1 and Data Testers provide a scalable, future-proof solution for the testing needs of engineers involved in the installation, commissioning, and maintenance of digital networks. These instruments can carry out both framed and unframed tests on a wide variety of equipment, ensuring that technicians can perform their jobs quickly and efficiently. This low cost, time saving, multiple language solution for E1 and datacom testing supports a wide range of software options, including Jitter and Frame Relay, all implemented on the same straightforward user interface.

The range of products comprises PA-20, PA-25, PF-30, PFA-30 and PFA-35. The PA-20 and PA-25 are multipurpose field service testers designed for commissioning, maintenance, and troubleshooting on E1 PCM circuits. They can perform a wide variety of tests, including: framed and unframed monitoring, framed and unframed end-to-end testing, drop and insert, channel associated signaling monitoring, Round Trip Delay measurement and repeated BERT.

The PF-30, PFA-30 and PFA-35 have a similar range of features for E1 circuit testing, plus an extended range of interfaces for data circuit and primary multiplexer testing.

Some of the key functions and benefits of the E1 and Data testers include:

Ease of use

The PA/PFA range has been designed with the technician in mind. The instruments are lightweight, easy to hold and carry, and feature a large LCD screen with integral backlight for the most demanding testing environments.

Rapid fault identification

Test results are displayed in a concise, graphical format with our recognized big “OK” when no errors or alarms are present (figure 1). The testers also support multiple languages. With comprehensive alarm and errors status LEDs, technicians are given a clear indication of problems even at a distance. All results and data can be stored for later analysis and printed to an external printer or computer with a single key press.

Autoconfigure

The autoconfigure feature greatly simplifies instrument setup. A test can be started on framed or unframed traffic using just two key presses. For a framed signal the instrument can determine the framing type, timeslot allocation and test pattern type.

Gelbrich synchronization

The patented Gelbrich synchronization method enables test pattern synchronization and accurate BERT measurement even in the presence of rapid bursts of errors. It also differentiates between bit slips and bit errors, important in QoS testing.

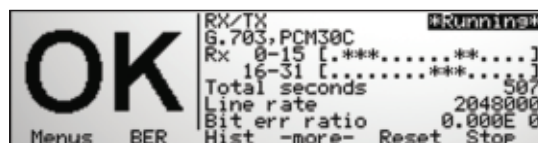


figure 1

Results storage and printing

The PA/PFA range of instruments has eight configuration and test memories that store test configurations and results, allowing them to be viewed or printed at a later time. Results are printed through the serial port and a setup screen enables the instrument to be set for a range of serial printers. Parallel printers are supported with the use of a serial to parallel converter cable. Alternatively, printing to a PC can be achieved using a software program such as WG Print Capture.

Remote operation and control

The PA/PFA range of E1 and Data testers is compatible with the DTM-32 remote operation solution. This offers remote operation of the instrument using an on-screen faceplate, via an easy-to-use Windows™ interface. Remote control commands are available for integration into network management software.

Programmable timers

The instrument can be programmed to start a delayed test at a specific date and time for a selectable duration.

Battery/mains operation

For field use, the instrument has an 8-10 hour battery life using rechargeable and exchangeable batteries. Long duration testing can be achieved using the combined AC mains power supply and charger.

Software options

A key feature of the PA-25 and PFA-35 instruments is the ability to load software options to extend testing functionality.

Accessories

The ELM-2 accessory allows the instrument to be connected to 2 Mbps lines carrying hazardous voltages and $\pm f$ distortion. It removes the DC voltage, equalizes the voltage signal and also measures and displays the signal level.

The V.11 cable test adapter is used to detect a number of common faults on V.11 cables that might otherwise go unnoticed due to the nature of balanced line interfaces.



Feature summary

	E1 Testers		E1 and Datacom Testers		
	PA-20	PA-25	PF-30	PFA-30	PFA-35
General features					
Remote operation and control	•	•	•	•	•
Autoconfigure	•	•	•	•	•
Test patterns, fixed, programmable and ITU-T	•	•	•	•	•
Local language support	•	•	•	•	•
Downloadable software options	•	•	•	•	•
Test configuration and results memories	•	•	•	•	•
Printer interface	•	•	•	•	•
Programmable timer	•	•	•	•	•
Backlight	•	•	•	•	•
LEDs	•	•	•	•	•
Large display	•	•	•	•	•
E1 circuit testing					
Balanced and unbalanced G.703 Tx and Rx	•	•	•	•	•
Terminated and high impedance termination modes	•	•	•	•	•
Framed and unframed test signal generation	•	•	•	•	•
n and m x 64 kbps time slot monitoring	•	•	•	•	•
Pattern generation into n and m x 64 kbps timeslots	•	•	•	•	•
G.821, G.826, M.2100 Analysis (both IS and OOS)	•	•	•	•	•
Error and alarm, generation and analysis	•	•	•	•	•
PCM tone generation with variable level and frequency	•	•	•	•	•
PCM decoding and audio output	•	•	•	•	•
CAS monitoring of all 30 channels	•	•	•	•	•
CAS history for a single channel	•	•	•	•	•
E1 signal Through mode	•	•	•	•	•
n x 64 kbps drop or n x 64 kbps insert	•	•	•	•	•
m x 64 kbps drop and insert	•	•	•	•	•
Si, Sa, A and E monitoring and generation	•	•	•	•	•
NFAS and NMFAS monitoring and generation	•	•	•	•	•
Tx frequency offset	•	•	•	•	•
Round trip delay, framed and unframed	•	•	•	•	•
Primary multiplexer testing					
Pattern into MUX channel and monitoring on E1 signal	•	•	•	•	•
Pattern into E1 signal and monitoring on MUX channel	•	•	•	•	•
X.50 multiplexer testing					
					•
Datacom circuit testing					
X.21 V.11/RS422 interface	•	•	•	•	•
V.24/RS232 interface (sync and async)	•	•	•	•	•
V.35 interface via adapter	•	•	•	•	•
V.36/RS449 interface via adapter	•	•	•	•	•
EIA530 interface via adapter	•	•	•	•	•

Accessories

Unbalanced 75 Ω BNC 2m (x4)	K169
Type 43 stub adapter cable (for above)	K1549
Balanced 120 Ω CF to 3 x Banana 2m (x4)	K71
Balanced 120 Ω CF to RJ45	K1597
BNC to Siemens 1.6/5.6	K1616
External clock adapter	K1513
V.24 download cable	K1515
Serial printer cable (25 way)	K1500
Serial to parallel printer cable	K1589
V.11 DCE adapter cable	K1505
V.24 DCE adapter cable	K1512
V.35 DTE (AMP 1.6 mm) adapter cable	K1508
V.35 DCE (AMP 1.6 mm) adapter cable	K1509
V.35 DTE (Positronic 1.6 mm) adapter cable	K1525
V.35 DCE (Positronic 1.6 mm) adapter cable	K1526
V.35 DTE (Positronic 1.0 mm) adapter cable	K1510
V.35 DCE (Positronic 1.0 mm) adapter cable	K1511
V.36/RS449 DTE adapter cable	K1506
V.36/RS449 DCE adapter cable	K1507
EIA-530 DCE adapter cable	K1629
EIA-530 DTE adapter cable	K1630
TSM-10 remote operation software	BN 4597/10
ELM-2 Equalizer Level Meter	BN 4546/01
V.11 cable test adapter	BN 4534/00.37
Equipment case (small)	BN 4523/00.04
Equipment case (large)	BN 4540/00.02
Soft carrying case	BN 4518/00.08

Software options (available at extra cost)

X.50	BN 4535/00.14
GSM	BN 4534/00.15
G.826	BN 4534/00.34
All 1's/All 0's histogram	BN 4534/00.20
M.2100	BN 4534/00.13
Noise Measurement	BN 4534/00.23
V Interface Status Monitor	BN 4535/00.28
V.110	BN 4535/00.32
HCM	BN 4535/00.35
Frame Relay (Enhanced)	BN 4535/00.41
Jitter	BN 4534/00.42
Datacom	BN 4534/00.44
V Delay	BN 4534/00.48
French S/C bits	BN 4534/00.11
Large Frequency Offset	BN 4534/00.19
PCM Alarm Analysis	BN 4534/00.26
Extended PRBS	BN 4534/00.36

Technical specification**Generator/Receiver****Interfaces**

G.703
X.21/V.11
V.24 (RS232)
V.35 via adapter
V.36 (RS449) via adapter
EIA530 via adapter

Physical Connections

3 pin CF connectors (120 Ω balanced)
BNC connectors (75 Ω unbalanced)
15 way D type (100 Ω balanced)
25 way D type

G.703 Test modes

RX mode	
Framing	PCM30, PCM30CRC, PCM31, PCM31CRC or unframed
G.703 line code	HBD3, AMI, codirectional
V.11 Drop	n x 64 kbps, m x 64 kbps

RX/TX

As RX plus:	BER test pattern generation n x 64 kbps, m x 64 kbps
V.11 Drop/Insert	Drop or insert n and m x 64 kbps Drop and insert n x 64 kbps

2 Mbps internal clock offset up to ±150ppm
Programmable Si, Sa, A and E bits and NMFAS

Through mode

As RX/TX modex plus:	Drop and insert n and m x 64 kbps
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Round Trip Delay mode

Framed and unframed 2 Mbps	
Range	0-10s
Resolution	1µs

MUX/DEMUX mode

G.703 interface as RX/TX mode
Unframed DTE emulation on V.11, V.24, V35, V.36

Monitor mode

Simultaneous monitoring and display of any time slot in both frame and multiframe.
Simultaneous monitoring and generation of the Si, Sa, A and E bits of the NFAS.
Simultaneous monitoring and generation of the NMFAS.

Level and Frequency mode

PCM generation and measurement of sinusoidal signals in a time slot. (A-law coding to ITU-T Rec. G.711)	
Tx frequency range	5 Hz to 3998 Hz
Tx level range	-55 dBm0 to +3 dBm0
Rx level measurements	-80 dBm0 to +5 dBm0

X.50 Test modes

RX/TX, through, D&I and MUX/DEMUX
Division 2 and 3 framing
Test pattern insertion/evaluation in n x 600, 19.2, 48 kbps
X.50 frame analysis
Programmable A-H bits

Test patterns

2E6-1, 2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1

Alternating 1s and 0s, All 1s, All 0s

8 and 16 bit programmable words

Error injection

Bit, code, FAS,
CRC errors Single, ratio or frequency

Clocking

G.703 transmit clock source 2048 kbps and co-dir
Internal, external, from RX

Printer and remote operation

Interface	V.24, DTE, Async
Baud rates	300, 600, 1200, 2400, 9600, 19200, 38400

Front panel

Display	42 character x 16 line LCD with backlight
LEDs	2 summary, 14 alarm/error, option and low battery
Keyboard	Numeric keypad, 4 cursor, 2 contrast, main menu, 6 soft keys, alt, on and off

Stores/Memory

8 test configuration stores and 8 test results memories

Self check

Comprehensive self check at power on

Languages

English, German, French, Spanish, Italian, Turkish and Portuguese

Power Supply

Internal supply	Rechargeable NiCd batteries (8 to 10 hours operating time)
External supply	External mains adapter/charger Low battery warning LED before auto switch off

Weight/Dimensions

Weight	1.55 kg approximately
Dimensions (h x d x w)	72 x 136 x 195 mm

Ordering information

JDSU E1 Tester PA-20	BN 4525/50
JDSU E1 Tester PA-25	BN 4542/50
JDSU E1 and Data Tester PF-30	BN 4526/50
JDSU E1 and Data Tester PFA-30	BN 4523/50
JDSU E1 and Data Tester PFA-35	BN 4535/60
JDSU E1 and Data Tester PFA-35 with X.50	BN 4535/50

All complete with AC adapter/charger
Plug for US, Euro, UK or Australian voltage
User manual

All statements, technical information and recommendations related to the products herein are based upon information believed to be reliable or accurate. However, the accuracy or completeness thereof is not guaranteed, and no responsibility is assumed for any inaccuracies. The user assumes all risks and liability whatsoever in connection with the use of a product or its application. JDSU reserves the right to change at any time without notice the design, specifications, function, fit or form of its products described herein, including withdrawal at any time of a product offered for sale herein. JDSU makes no representations that the products herein are free from any intellectual property claims of others. Please contact JDSU for more information. JDSU and the JDSU logo are trademarks of JDS Uniphase Corporation. Other trademarks are the property of their respective holders. ©2005 JDS Uniphase Corporation. All rights reserved. 10143206 500 1005 E1PAPFA.DS.ACC.TM.AE

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